

# **RU30P5D-VB Datasheet**

# P-Channel 35 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)			
- 35	0.040 at V <sub>GS</sub> = - 10 V	- 6.2	9.8 nC			
- 35	0.048 at V <sub>GS</sub> = - 4.5 V	- 5.1	9.6110			

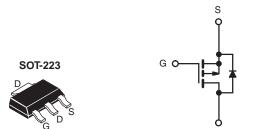
### **FEATURES** • Halogen-free According to IEC 61249-2-21 **Definition**



- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT HALOGEN FREE



P-Channel MOSFET

#### **APPLICATIONS**

- · Load Switches, Adaptor Switch
  - Notebook PCs

ABSOLUTE MAXIMUM RATINGS	T <sub>A</sub> = 25 °C, unless oth	erwise noted)		
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	- 35	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		- 6.2	
Continuous Drain Current (T = 150 °C)	T <sub>C</sub> = 70 °C		- 4.8	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 4.5 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		- 3.4 <sup>a, b</sup>	Α
Pulsed Drain Current		I <sub>DM</sub>	- 20	A
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		- 3.5	
	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 2.1 <sup>a, b</sup>	
Avalanche Current	1 0.1 ml l	I <sub>AS</sub>	- 10	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	5	mJ
	T <sub>C</sub> = 25 °C		4.2	
Maximum Davier Dissination	T <sub>C</sub> = 70 °C		2.7	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C		1.6 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	R <sub>thJA</sub>	40	50	°C/W	
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	24	30	C/VV	

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 85 °C/W.
- d. Based on  $T_C$  = 25 °C.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•			
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 35			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 vA		- 42		m\//0/	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		4.6		- mv/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.6		- 1.8	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Oaka Walka wa Busin Oawand		V <sub>DS</sub> = - 35 V, V <sub>GS</sub> = 0 V			- 1		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = - 35 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 10			Α	
D : 0		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A		0.040			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 4 A		0.048		μΑ	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 5 A		14		S	
Dynamic <sup>b</sup>				•	<b>'</b>		
Input Capacitance	C <sub>iss</sub>			970			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		120		V mV/°C V nA μA Ω S	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			95			
T		V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A		23	35		
Total Gate Charge	$Q_g$			9.8	16		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		3		nC	
Gate-Drain Charge	$Q_{gd}$			5.2			
Gate Resistance	$R_g$	f = 1 MHz	1.0	5.5	11	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			7	14		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 20 V, $R_L$ = 4 $\Omega$		12	24		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		30	60		
Fall Time	t <sub>f</sub>			9	18		
Turn-On Delay Time	t <sub>d(on)</sub>			44	80	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 20 V, $R_L$ = 4 $\Omega$		33	60		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		28	55		
Fall Time	t <sub>f</sub>			13	25		
<b>Drain-Source Body Diode Characterist</b>	ics			•			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 3.5		
Pulse Diode Forward Current	I <sub>SM</sub>				- 20	) A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 2 A, V <sub>GS</sub> = 0 V		- 0.76	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			27	50	ns	
Body Diode Reverse Recovery Charge	de Beverse Becovery Charge Q			19	35	nC	
Reverse Recovery Fall Time	ta	$I_F = -2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		14			
Reverse Recovery Rise Time	t <sub>b</sub>	1 -		13		ns ns	

#### Notes:

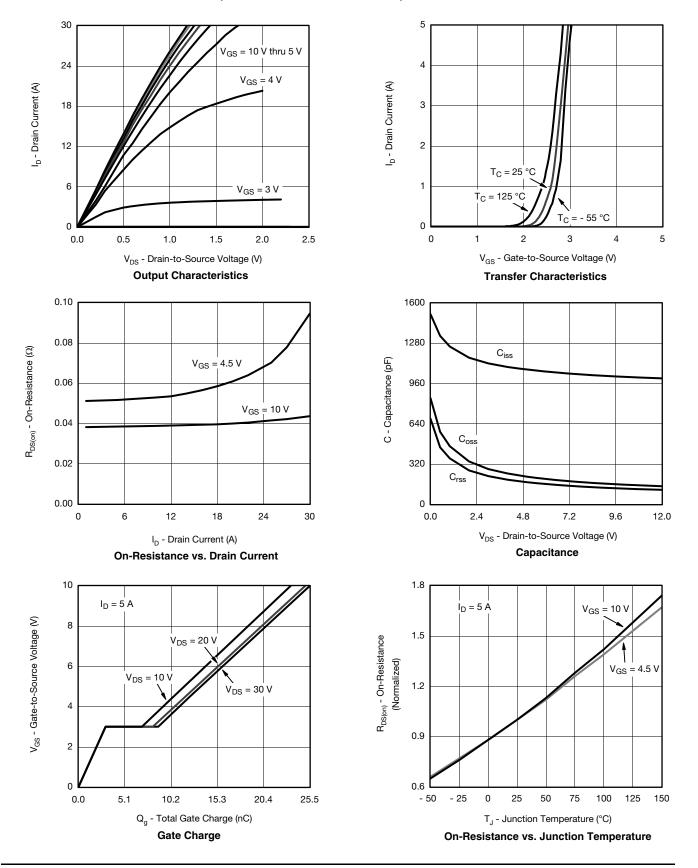
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- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

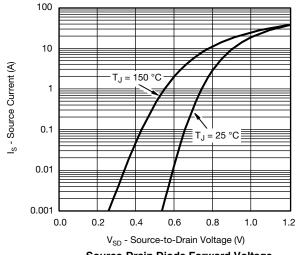


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

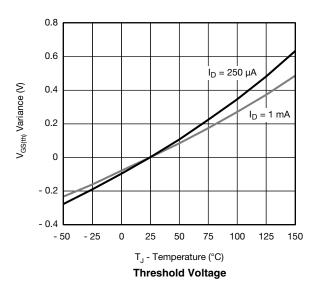


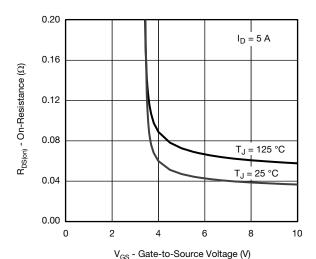


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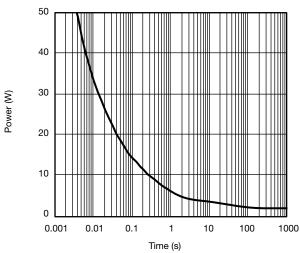


#### Source-Drain Diode Forward Voltage

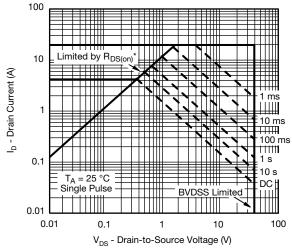




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

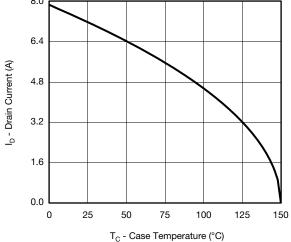


 $V_{DS}$  - Drain-to-Source voltage (v) \*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

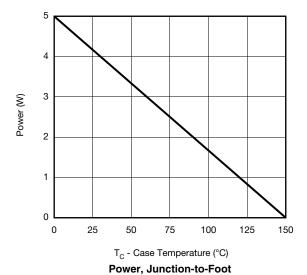
Safe Operating Area

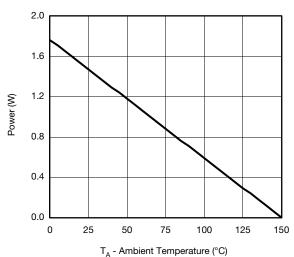


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



## **Current Derating\***





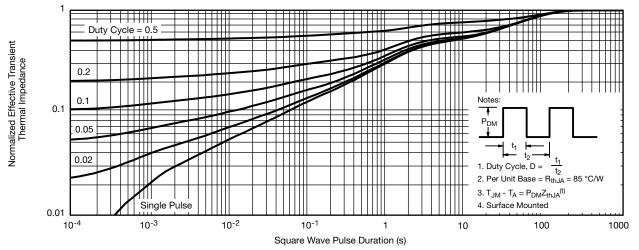
Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

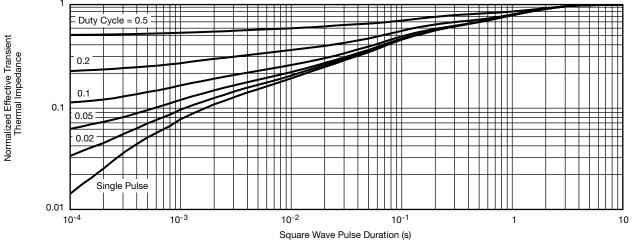
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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



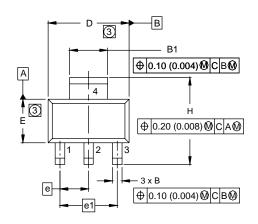
Normalized Thermal Transient Impedance, Junction-to-Ambient

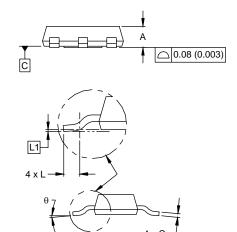


Normalized Thermal Transient Impedance, Junction-to-Foot



## **SOT-223 (HIGH VOLTAGE)**





DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	1.55	1.80	0.061	0.071
В	0.65	0.85	0.026	0.033
B1	2.95	3.15	0.116	0.124
С	0.25	0.35	0.010	0.014
D	6.30	6.70	0.248	0.264
Е	3.30	3.70	0.130	0.146
е	2.30	2.30 BSC		5 BSC
e1	4.60	BSC	0.181	BSC
Н	6.71	7.29	0.264	0.287
L	0.91	-	0.036	=
L1	0.061 BSC		0.002	4 BSC
θ	-	10'	-	10'

ECN: S-82109-Rev. A, 15-Sep-08

DWG: 5969

#### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension do not include mold flash.
- 4. Outline conforms to JEDEC outline TO-261AA.



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